SPECIFICATION

SPEC. No. A-Open-b D A T E: 2015 Jan.

То

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS

CGA Series / Automotive Grade

Open Mode

Please return this specification to TDK representatives. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group TDK-EPC Corporation

Engineering

Ceramic Capacitors Business Group

| APPROVED | Person in charge |
|----------|------------------|
| | |
| | |
| | |

| APPROVED | CHECKED | Person in charge |
|----------|---------|------------------|
| | | |
| | | |
| | | |

1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan,

TDK(Suzhou)Co.,Ltd and TDK Components U.S.A. Inc.

EXPLANATORY NOTE:

This specification warrants the quality of the ceramic chip capacitors. The chips should be evaluated or confirmed a state of mounted on your product.

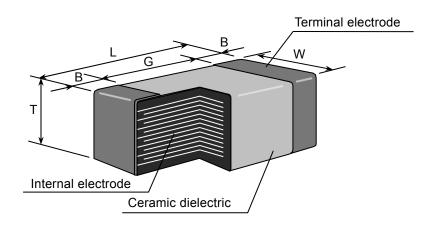
If the use of the chips goes beyond the bounds of the specification, we can not afford to guarantee.

2. CODE CONSTRUCTION

(Example)

(3) 104 125 Catalog Number: M (2) (5) (8) (6) (10)(Web) Item Description: CGA4 104 1H (2) (3) (11)(5) (6) (7) (4) (12)

(1) Type



Please refer to product list for the dimension of each product.

(2) Thickness

* As for dimension tolerance, please contact with our sales representative.

| Thickness | Dimension(mm) |
|-----------|---------------|
| F | 0.85 |
| J | 1.25 |

(3) Voltage condition in the life test (Max. operating Temp./1000h)

| Sign | Condition |
|------|-------------------|
| 2 | Rated Voltage x 2 |

(4) Temperature Characteristics (Details are shown in table 1 No.6 at page 5)



(5) Rated Voltage

| Symbol | Rated Voltage | |
|--------|---------------|--|
| 1 H | DC 50 V | |

(6) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example 104 \rightarrow 100,000 pF

(7) Capacitance tolerance

| Symbol | Tolerance |
|--------|-----------|
| K | ± 10 % |

- (8) Thickness code (Only Catalog Number)
- (9) Package code (Only Catalog Number)
- (10) Special code (Only Catalog Number)
- (11) Packaging (Only Item Description)

| Symbol | Packaging | |
|--------|-----------|--|
| В | Bulk | |
| Т | Taping | |

(12) Internal code (Only Item Description)

3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

3.1 Standard combination of rated capacitance and tolerances

| Class | Temperature Characteristics | Capacitance tolerance | | Rated capacitance |
|-------|--------------------------------|-----------------------|------------|-------------------|
| 2 | X7R X8R | 10uF and under | K (± 10 %) | E – 6 series |

3.2 Capacitance Step in E series

| E series | Capacitance Step | | | | | |
|----------|------------------|-----|-----|-----|-----|-----|
| E- 6 | 1.0 | 1.5 | 2.2 | 3.3 | 4.7 | 6.8 |

4. OPERATING TEMPERATURE RANGE

| T.C. | Min. operating Temperature | Max. operating Temperature | Reference Temperature |
|------|-------------------------------|-------------------------------|--------------------------|
| X7R | -55°C | 125°C | 25°C |
| X8R | -55°C | 150°C | 25°C |

5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

8. PERFORMANCE

table 1

| Item | Performance | Test or inspection method |
|-----------------------|--|---|
| External Appearance | No defects which may affect performance. | Inspect with magnifying glass (3×) |
| Insulation Resistance | 10,000MΩ or 500MΩ·μF min. whichever smaller. | Apply rated voltage for 60s. |
| Voltage Proof | Withstand test voltage without insulation breakdown or other | Class Apply voltage |
| | damage. | Class2 2.5 × rated voltage |
| | | Above DC voltage shall be applied for 1 to 5s. Charge / discharge current shall not exceed 50mA. |
| Capacitance | Within the specified tolerance. | Class Measuring Measuring frequency voltage |
| | | Class2 1kHz±10% 1.0±0.2Vms. |
| Dissipation Factor | T.C. D.F. | See No.4 in this table for measuring condition. |
| | X7R X8R 0.03 max. | |
| | External Appearance Insulation Resistance Voltage Proof Capacitance | External Appearance No defects which may affect performance. Insulation Resistance 10,000ΜΩ or 500ΜΩ·μF min. whichever smaller. Voltage Proof Withstand test voltage without insulation breakdown or other damage. Capacitance Within the specified tolerance. Dissipation Factor T.C. D.F. |

| No. | Item | Performance | Test or inspection method | | |
|-----|--|--|---|--|--|
| 6 | Temperature Characteristics of Capacitance | Capacitance Change (%) | Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each | | |
| | | No voltage applied | | | |
| | | X7R: ±15 X8R: ±15 | step. ΔC be calculated ref. STEP3 reading Step Temperature(°C) | | |
| | | | 1 Reference temp. ± 2 | | |
| | | | 2 Min. operating temp. ± 2 | | |
| | | | 3 Reference temp. ± 2 | | |
| | | | 4 Max. operating temp. ± 2 | | |
| 7 | Robustness of Terminations | No sign of termination coming off, breakage of ceramic, or other abnormal signs. | Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b and apply a pushing force of 17.7N with 10±1s. Pushing force Capacitor P.C.Board | | |
| 8 | Bending | No mechanical damage. | Reflow solder the capacitors on a P.C.Board shown in Appendix 2 and bend it for 2mm. (1mm is applied for 0.85mm thickness of Class2 items.) | | |
| | | | R230 (Unit : mi | | |

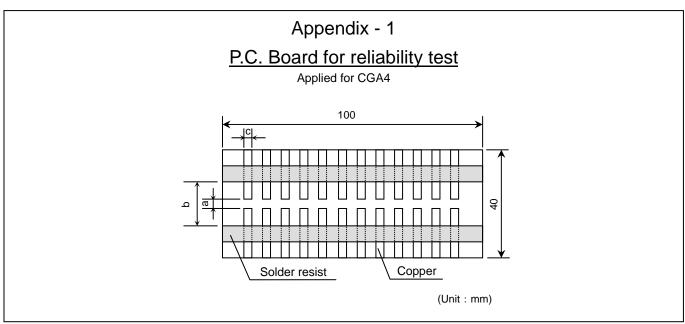
| No. | Ite | em | Perfo | ormance | Test or inspection method |
|-----|---------------------------------|--------------------------|--|-----------------------------------|---|
| 9 | Solderability | | New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. | | Completely soak both terminations in solder at 235±5°C for 2±0.5s. Solder: H63A (JIS Z 3282) |
| | | | Ceramic surface of A sections shall not be exposed due to melting or shifting of termination material. | | Flux: Isopropyl alcohol (JIS K 8839) Rosin(JIS K 5902) 25% solid solution. |
| 10 | Resistance to solder heat | External appearance | No cracks are allowed and terminations shall be covered at least 60% with new solder. | | Completely soak both terminations in solder at 260±5°C for 5±1s. Preheating condition |
| | | Capacitance | Characteristics | Change from the value before test | Temp. : 150±10°C Time : 1 to 2min. |
| | | | X7R X8R | ± 7.5 % | Flux: Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. |
| | | D.F. | Meet the initial | spec. | Solder : H63A (JIS Z 3282) |
| | | Insulation Resistance | Meet the initial spec. | | Leave the capacitors in ambient condition for 24±2h before measurement. |
| | | Voltage proof | No insulation brother damage. | reakdown or | |

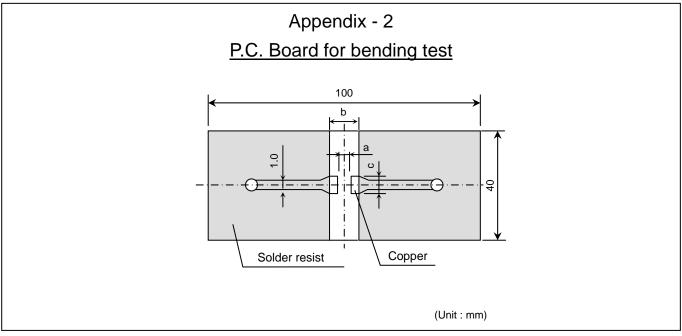
| No. | Ite | em | Performance | | | Test or inspection method | | |
|-----|-------------------|---------------------------------|--|---|--|---|-------------|--|
| 11 | Vibration | External appearance Capacitance | No mechanical Characteristics X7R | Change from the value before test | Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing. Vibrate the capacitor with following conditions. Applied force: 5G max. Frequency: 10-2000Hz Duration: 20 min. Cycle: 12 cycles in each 3 mutually perpendicular directions. | | dix 1a or | |
| | | D.F. | X8R Meet the initial | | | | mutually | |
| 12 | Temperature cycle | External appearance Capacitance | No mechanical damage. | | P.C.Bo | Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing. | | |
| | | | Characteristics X7R X8R | Change from the value before test ± 7.5 % | Expose the capacitors in th step1 through step 4 and re times consecutively. | | | |
| | | D.F. Insulation | Meet the initial spec. Meet the initial spec. | | Leave the capacitors in ambient condition for 24±2h before measurement. | | | |
| | | Resistance | | • | Step | Temperature(°C) | Time (min.) | |
| | | Voltage proof | other damage. | No insulation breakdown or other damage. | | Min. operating temp. ±3 | 30 ± 3 | |
| | | | | | 2 | Reference Temp. | 2 - 5 | |
| | | | | | 3 | Max. operating temp. ±2 | 30 ± 2 | |
| | | | | | 4 | Reference Temp. | 2 - 5 | |
| | | | | | | | 1 | |

| No. | Ite | em | Perf | ormance | Test or inspection method | |
|-----|------------------------|--------------------------|--|-----------------------------------|---|--|
| 13 | Moisture Resistance | External appearance | No mechanical | damage. | Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or | |
| | (Steady State) | Capacitance | Characteristics | Change from the value before test | Appendix 1b before testing. Leave at temperature 40±2°C, 90 to | |
| | | | X7R X8R | ± 12.5 % | 95%RH for 500 +24,0h. | |
| | | D.F. | Characteristics 200% of initial | spec. max. | Leave the capacitors in ambient condition for 24±2h before measurement. | |
| | | Insulation Resistance | 1,000MΩ or 50MΩ·μF min. whichever smaller. | | | |
| 14 | Moisture Resistance | External appearance | No mechanical damage. | | Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing. | |
| | | Capacitance | | | Appendix 16 before testing. | |
| | | | Characteristics | Change from the value before test | Apply the rated voltage at temperature 85°C and 85%RH for 1,000 +48,0h. | |
| | | | X7R X8R | ± 12.5 % | Charge/discharge current shall not exceed 50mA. | |
| | | D.F. | Characteristics 200% of initial | spec. max. | Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement. | |
| | | Insulation Resistance | 500MΩ or 25MΩ·μF min. whichever smaller. | | Voltage conditioning (only for class2) Voltage treat the capacitor under testing temperature and voltage for 1hour. Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value. | |

| No. | Item | | Perf | formance | Test or inspection method | |
|-----|------|--------------------------|--|-----------------------------------|---|--|
| 15 | Life | External appearance | No mechanical damage. | | Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing. | |
| | | Capacitance | Characteristics | Change from the value before test | Below the voltage shall be applied at maximum operating temperature ±2°C | |
| | | | X7R X8R | ± 15 % | for 1,000 +48, 0h. Applied voltage | |
| | | | Rated voltage x2 | | | |
| | | D.F. | Characteristics 200% of initial | | For information which product has which applied voltage, please contact with our sales representative. | |
| | | Insulation Resistance | 1,000M Ω or 50M Ω ·μF min. | | Charge/discharge current shall not exceed 50mA. | |
| | | | whichever sma | aller. | Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement. | |
| | | | | | Voltage conditioning (only for class2) Voltage treat the capacitor under testing temperature and voltage for 1hour. | |
| | | | | | Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value. | |

^{*}As for the initial measurement of capacitors (Class2) on number 6,10,11,12 and 13, leave capacitors at 150 -10,0°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.





Material: Glass Epoxy (As per JIS C6484 GE4)

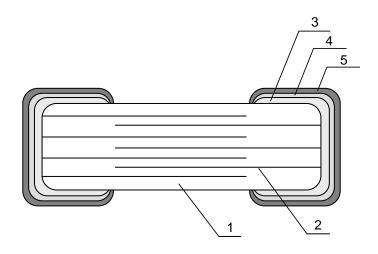
| TDK (EIA style) | Dimensions (mm) | | | |
|-----------------|-----------------|-----|------|--|
| , , | а | b | С | |
| CGA4 (CC0805) | 1.2 | 4.0 | 1.65 | |

P.C. Board thickness: 1.6mm

Copper (thickness 0.035mm)

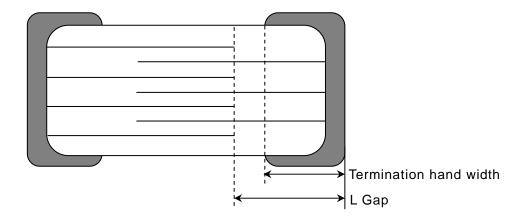
Solder resist

9. INSIDE STRUCTURE AND MATERIAL



| No. | NAME | MATERIAL |
|-----|-------------|-------------|
| 1 | Dielectric | BaTiO₃ |
| 2 | Electrode | Nickel (Ni) |
| 3 | | Copper (Cu) |
| 4 | Termination | Nickel (Ni) |
| 5 | | Tin (Sn) |

10. DESIGN CONCEPT OF THE OPEN-MODE



< L gap>

Distance between the end of the opposite electrode and the termination.

L Gap > Terminal band width

When a chip capacitor is cracked by mechanical stress such as board bending, open-mode construction helps to reduce the risk of short circuits.

Open-mode is a product design concept, and it is predicted that open-mode construction will result in a decreased number of shorts in our capacitors.

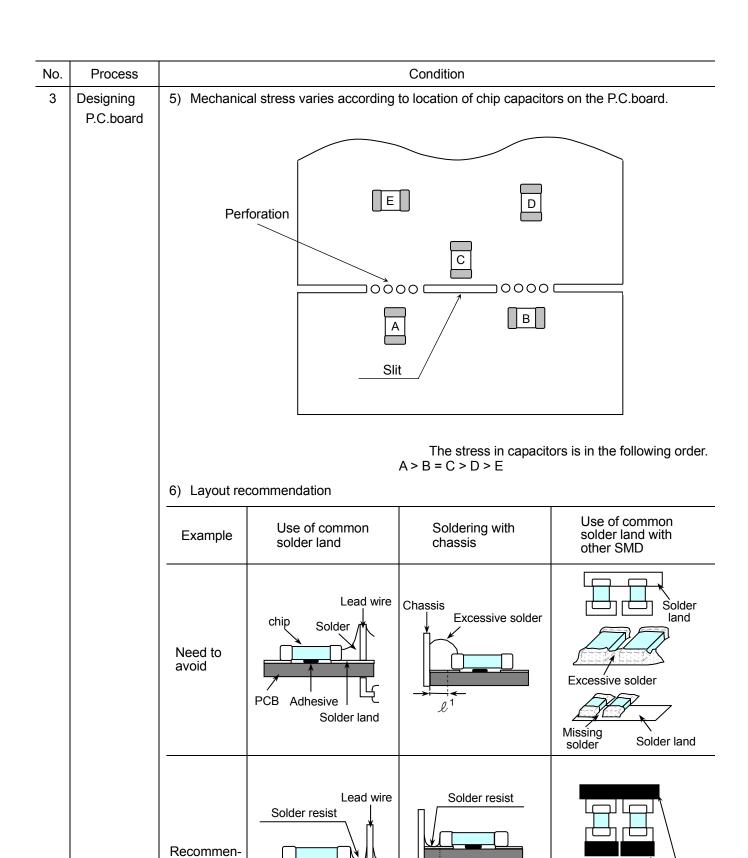
However because we can not predict the specific types of mechanical stress the capacitors will be subjected to, we can not guarantee absolute success.

11. Caution

| | Caution | T | | | | | | |
|-----|-------------------------------------|--|--|--|--|--|--|--|
| No. | Process | Condition | | | | | | |
| 1 | Operating Condition (Storage, | 1-1. Storage1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt. | | | | | | |
| | Transportation) | The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur. | | | | | | |
| | | 3) Avoid storing in sun light and falling of dew. | | | | | | |
| | | 4) Do not use capacitors under high humidity and high and low atmospheric pressur which may affect capacitors reliability. | | | | | | |
| | | 5) Capacitors should be tested for the solderability when they are stored for long time. | | | | | | |
| | | 1-2. Handling in transportation | | | | | | |
| | | In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 Handling in transportation) | | | | | | |
| 2 | Circuit design | 2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially | | | | | | |
| | <u> </u> | be careful with maximum temperature. 1) Do not use capacitors above the maximum allowable operating temperature. | | | | | | |
| | | 2) Surface temperature including self heating should be below maximum operating temperature. | | | | | | |
| | | (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C) | | | | | | |
| | | 3) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration. | | | | | | |
| | | 2-2. Operating voltage1) Operating voltage across the terminals should be below the rated voltage. | | | | | | |
| | | When AC and DC are super imposed, V _{0-P} must be below the rated voltage. (1) and (2) | | | | | | |
| | | AC or pulse with overshooting, V _{P-P} must be below the rated voltage. (3), (4) and (5) | | | | | | |
| | | When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage. | | | | | | |
| | | Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage | | | | | | |
| | | Positional Measurement (Rated voltage) 0 V _{0-P} 0 | | | | | | |
| | | Voltage (4) Pulse voltage (A) (5) Pulse voltage (B) | | | | | | |
| | | Positional Measurement (Rated voltage) | | | | | | |

| No. | Process | Condition | | | | | | |
|--|-----------------------------|---|--|--|--|--|--|--|
| 2 | Circuit design ⚠ Caution | Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced. | | | | | | |
| | | The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration. | | | | | | |
| | | 2-3. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound. | | | | | | |
| 3 | Designing | The amount of solder at the terminations has a direct effect on the reliability of the capacitors. | | | | | | |
| | P.C.board | The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations. | | | | | | |
| | | Avoid using common solder land for multiple terminations and provide individual solder land for each terminations. | | | | | | |
| 3) Size and recommended land dimensions. | | | | | | | | |
| | Chip capacitors Solder land | | | | | | | |
| | | Solder resist | | | | | | |
| | | Flow soldering (mm) | | | | | | |
| | | Type CGA4 Symbol (CC0805) | | | | | | |
| | | A 1.0 - 1.3 | | | | | | |
| | | B 1.0 - 1.2 | | | | | | |
| | | C 0.8 - 1.1 | | | | | | |
| | | Reflow soldering (mm) | | | | | | |
| | | Type CGA4 Symbol (CC0805) | | | | | | |
| | | Symbol (CC0805) A 0.9 - 1.2 | | | | | | |
| | | B 0.7 - 0.9 | | | | | | |
| | | C 0.9 - 1.2 | | | | | | |
| | | | | | | | | |

| No. | Process | | Condition | | | | |
|-----|------------------------|------------------------------------|--|---|--|--|--|
| 3 | Designing P.C.board | 4) Recommended | Recommended chip capacitors layout is as following. | | | | |
| | | | Disadvantage against bending stress | Advantage against bending stress | | | |
| | | Mounting face | Perforation or slit | Perforation or slit | | | |
| | | | Break P.C.board with mounted side up. | Break P.C.board with mounted side down. | | | |
| | | Chip arrangement (Direction) | Mount perpendicularly to perforation or slit Perforation or slit | Mount in parallel with perforation or slit Perforation or slit | | | |
| | | Distance from slit | Closer to slit is higher stress $ \begin{pmatrix} \ell_1 \\ \ell_2 \end{pmatrix} $ | Away from slit is less stress | | | |
| | | | | | | | |

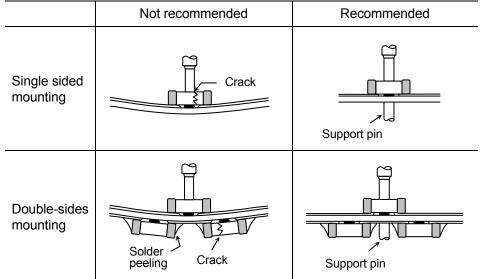


Solder resist

 $\ell^2 > \ell^1$

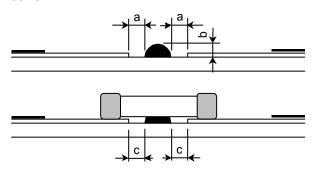
dation

| No. | Process | Condition | | | | |
|-----|----------|---|---|---|--|--|
| 4 | Mounting | capacitors to res 1) Adjust the bott surface and no 2) Adjust the mou | head is adjusted too low, it may include in cracking. Please take following om dead center of the mounting heat press it. unting head pressure to be 1 to 3N the impact energy from mounting heat per bottom side of the P.C. board. | ng precautions. ead to reach on the P.C.board of static weight. | | |
| | | | Not recommended | Recommended | | |



When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.

4-2. Amount of adhesive



Example: CGA4 (CC0805)

| а | 0.2mm min. |
|---|------------------------------|
| b | 70 - 100μm |
| С | Do not touch the solder land |
| | |

| No. | Process | | C | ondition | | |
|-----|-----------|---|--------------------|--------------------------|--------------------------------------|---|
| 5 | Soldering | 5-1. Flux selection Although highly-activated flux gives better solderability, substances which increase activity may also degrade the insulation of the chip capacitors. To avoid such degradation, it is recommended following. 1) It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. | | | | |
| | | 2) Excessive flux must b | | | | |
| | | 3) When water-soluble f | flux is used, eno | ugh washing is | necessary. | |
| | | 5-2. Recommended sold | ering profile by \ | various method | S | |
| | | Wave sold Solde | - | → ← | Reflow solde So Preheating | ering oldering ≺→ ≺ Natural cooling |
| | | Peak Temp Over 60 sec. Peak Temp | Over 60 sec. | Peak Temp (O) dual Ove | r 60 sec. | ←→ Temp time |
| | | Manual soldering (Solder iron) APPLICATION | | | | |
| | | 300 ΔT Preheating | | As for solder | CGA4 (CC0805) aling and reflow solde | |
| | | 5-3. Recommended sold | ering peak temp | and peak tem | o duration | |
| | | Temp./Duration | Wave so | | Reflow so | oldering |
| | | Solder | Peak temp(°C) | Duration(sec.) | Peak temp(°C) | Duration(sec.) |
| | | Sn-Pb Solder | 250 max. | 3 max. | 230 max. | 20 max. |
| | | Lead Free Solder | 260 max. | 5 max. | 260 max. | 10 max. |
| | | Recommended solde Sn-37Pb (Sn-Pb sol Sn-3.0Ag-0.5Cu (Le | lder) |) | | |

| | Dragge | | Cond | ition | | |
|-----|-----------|--|--|--|---|--|
| No. | Process | Condition 5. 4. Avaiding the graph shock | | | | |
| 5 | Soldering | 5-4. Avoiding thermal shock1) Preheating condition | | | | |
| | | Soldering | | Туре | Temp. (°C) | |
| | | Wave soldering | CGA4(CC0805) | • | ΔT ≤ 150 | |
| | | Reflow soldering | CGA4(CC0805) | | ΔT ≤ 150 | |
| | | Manual soldering | CGA4(CC0805) | | ΔT ≤ 150 | |
| | | cleaning, the temperat 5-5. Amount of solder Excessive solder | ure difference (∆T will induce highe es and it may resu | must be less that tr tensile force in alt in chip cracking | dipped into a solvent for in 100°C. In chip capacitors when g. In sufficient solder may | |
| | | Excessive solder Higher tensile forchip capacitors to crack Maximum amount Minimum amount Minimum amount | | | | |
| | | | | | | |
| | | Insufficient solder | | cau chip | v robustness may use contact failure or use capacitors come off P.C.board. | |
| | | heat shock may cause Please make sure the time in accordance wi chip capacitors with the Recommended solds | ng iron tip Ider iron varies by the tip temperature e a crack in the che tip temp. before s th following recome ne condition in 5-4 er iron condition (S | e, the quicker the ip capacitors. soldering and keep mended condition to avoid the therm Sn-Pb Solder and | operation. However, of the peak temp and n. (Please preheat the nal shock.) Lead Free Solder) | |
| | | Temp. (°C) 300 max. | Duration (sec.) 3 max. | Wattage (W) 20 max. | Shape (mm) Ø 3.0 max. | |
| | | | Jillax. | ZU IIIdX. | 2 3.0 max. | |

| No. | Process | Condition |
|-----|-----------|---|
| 5 | Soldering | Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron. 5-7. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-8. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335B Annex 1 (Informative) Recommendations to prevent the |
| | | tombstone phenomenon) |
| 6 | Cleaning | If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance. |
| | | 2) If cleaning condition is not suitable, it may damage the chip capacitors. |
| | | 2)-1. Insufficient washing |
| | | (1) Terminal electrodes may corrode by Halogen in the flux. |
| | | (2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance. |
| | | (3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2). |
| | | 2)-2. Excessive washing |
| | | When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition. |
| | | Power : 20 W/ & max. |
| | | Frequency : 40 kHz max. |
| | | Washing time : 5 minutes max. |
| | | 2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning. |

| | _ | 1 | | |
|-------|--------------------------------------|---|---|---|
| No. | Process | | Condition | |
| 7 | Coating and molding of the P.C.board | When the P.C.board is coated, please verify the quality influence on the product. Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors. Please verify the curing temperature. | | |
| 8 | Handling after | 1) Please na | av attention not to hend or distort the | P.C.board after soldering in handling |
| 0 | chip mounted A Caution | , | the chip capacitors may crack. | e F.C.board after soldering in Handling |
| | | 2) When functional check of the P.C.board is performed, check pin pressure tends to be adjusted higher for fear of loose contact. But if the pressure is excessive and bend the P.C.board, it may crack the chip capacitors or peel the terminatio off. Please adjust the check pins not to bend the P.C.board. | | |
| | | Item | Not recommended | Recommended |
| | | Board bending | Termination peeling Check pin | Support pin Check pin |
| 9 | Handling of loose chip capacitors | 1) If dropped the chip capacitors may crack. Once dropped do not use it. Esp the large case sized chip capacitors are tendency to have cracks easily, so handle with care. Floor 2) Piling the P.C.board after mounting for storage or handling, the corner of the board may hit the chip capacitors of another board to cause crack. P.C.board Crack | | |

| No. | Process | Condition |
|-----|---|---|
| 10 | Capacitance aging | The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well. |
| 11 | Estimated life and estimated failure rate of capacitors | As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed. |
| 12 | Others A Caution | The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition. |
| | | The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us. |
| | | (1) Aerospace/Aviation equipment (2) Transportation equipment (electric trains, ships, etc.) (3) Medical equipment (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications |
| | | When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment. |

12. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F}$$
 $\underline{2}$ \underline{A} \underline{OO} \underline{OOO} (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

13. Bulk packaging quantity

Total number of components in a plastic bag for bulk packaging: 1,000pcs.

14. TAPE PACKAGING SPECIFICATION

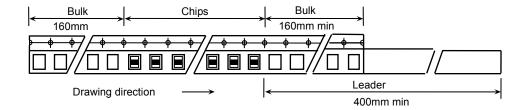
1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3.

Dimensions of plastic tape shall be according to Appendix 4,.

1-2. Bulk part and leader of taping

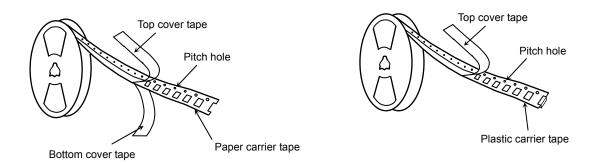


1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 5.

Dimensions of Ø330 reel shall be according to Appendix 6.

1-4. Structure of taping



2. CHIP QUANTITY

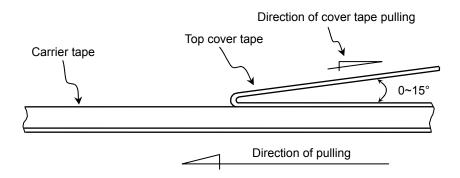
| Type | Thickness | Taping | Chip quantity(pcs.) | | |
|----------|-----------|-------------------|---------------------|-------------|--|
| Type | of chip | Material | φ178mm reel | φ330mm reel | |
| CGA4 | 0.85 mm | Paper *Plastic | 4,000 | 10,000 | |
| (CC0805) | 1.25 mm | Plastic | 2,000 | 10,000 | |



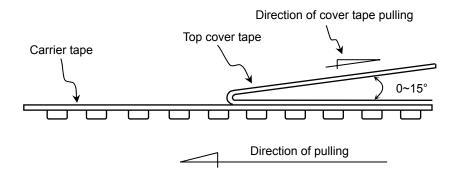
3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05-0.7N. (See the following figure.)

TYPE 1 (Paper)



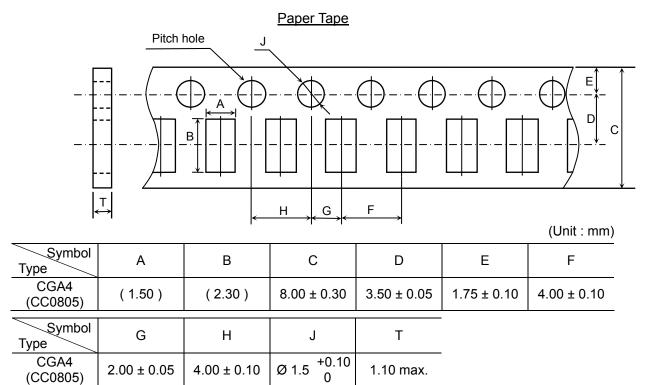
TYPE 2 (Plastic)



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.

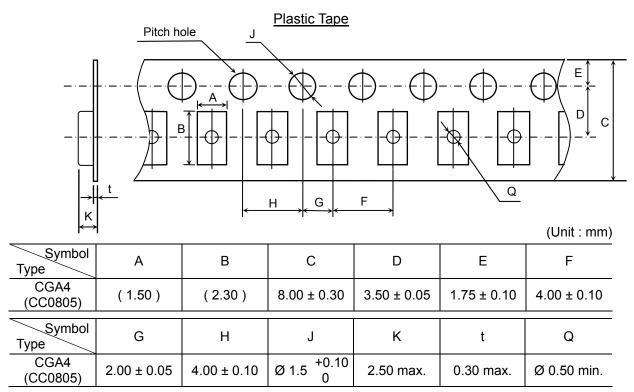


Appendix 3



^{*} The values in the parentheses () are for reference.

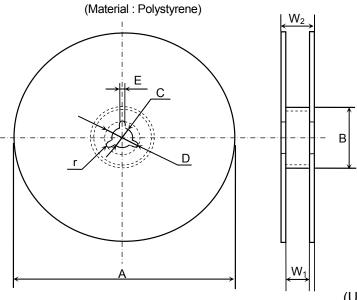
Appendix 4



^{*} The values in the parentheses () are for reference.

Appendix 5

CGA4



(Unit: mm)

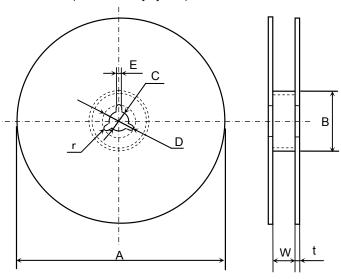
| Symbol | А | В | С | D | E | W ₁ |
|-----------|------------|-----------|-----------|-----------|-----------|----------------|
| Dimension | Ø178 ± 2.0 | Ø60 ± 2.0 | Ø13 ± 0.5 | Ø21 ± 0.8 | 2.0 ± 0.5 | 9.0 ± 0.3 |

| Symbol | W ₂ | r | |
|-----------|----------------|-----|--|
| Dimension | 13.0 ± 1.4 | 1.0 | |

Appendix 6

CGA4

(Material : Polystyrene)



(Unit: mm)

| Symbol | А | В | С | D | E | W |
|-----------|--------------------------------|----------|-----------|-----------|-----------|------------|
| Dimension | Ø382 max. (Nominal Ø330) | Ø50 min. | Ø13 ± 0.5 | Ø21 ± 0.8 | 2.0 ± 0.5 | 10.0 ± 1.5 |

| Symbol | t | r |
|-----------|-----------|-----|
| Dimension | 2.0 ± 0.5 | 1.0 |